## Search Notes



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Applicant(s)/Patent Under Reexamination

TIETSCHERT, HANKA

Examiner

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Art Unit

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## **SEARCHED**

Class	Subclass	Date	Examiner
206	521.1- 521.9	2/14/08	Blaine Neway
220	508	2/14/08	Blaine Neway
Update		7/8/08	Blaine Neway

## **SEARCH NOTES**

Search Notes	Date	Examiner
Consulted with Primary Examiner Luan Bui	2/6/08	Blaine Neway

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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